

EAST Search History

09/922,478

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	11294	self test device or built-in self test or in-circuit test or BIST or built-in test or self test circuit or self test unit or self test component	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S2	1727398	integrated circuit or IC	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S3	6642	S1 and S2	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S4	582967	external tester or external device or external test equipment or ATE or automatic test equipment	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S5	482046	(evaluat\$3 or analyz\$3) same (test result\$1 or result\$1)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S6	4071	S4 same S5	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S7	118	S6 and S3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28

EAST Search History

S8	36107	714/733 or 714/734 or 714/30 or 714/738 or 714/726 or 714/724 or 714/718 or 714/? or 365/200 or 365/201 or 716/4 or 326/30 or 326/?	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S9	71	S8 and S7	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S10	71	S9 and S3	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S11	71	S10 and S4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 12:28
S12	75153	(prevent\$3 or avoid\$3 or stop\$4 or disabl\$3 or disconnect\$3 or discontinu\$3) same (power or supply voltage or clock signal or clock) same (S2)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 17:06
S13	2	S12 and S11	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2007/10/22 14:11